

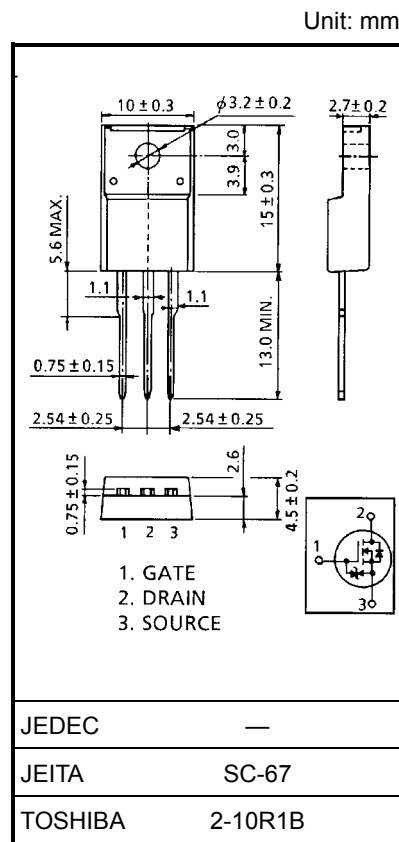
2SK3126

Switching Regulator, Applications

- Low drain-source ON resistance : $R_{DS}(\text{ON}) = 0.48 \, \Omega$ (typ.)
- High forward transfer admittance : $|Y_{fs}| = 7.5 \, \text{S}$ (typ.)
- Low leakage current : $I_{DSS} = 100 \, \mu\text{A}$ (max) ($V_{DS} = 450 \, \text{V}$)
- Enhancement-mode : $V_{th} = 2.4\text{--}3.4 \, \text{V}$ ($V_{DS} = 10 \, \text{V}$, $I_D = 1 \, \text{mA}$)

Maximum Ratings (Ta = 25°C)

Characteristics		Symbol	Rating	Unit
Drain-source voltage		V_{DSS}	450	V
Drain-gate voltage ($R_{GS} = 20\text{ k}\Omega$)		V_{DGR}	450	V
Gate-source voltage		V_{GSS}	± 30	V
Drain current	DC (Note 1)	I_D	10	A
	Pulse (Note 1)	I_{DP}	40	A
Drain power dissipation ($T_c = 25^\circ\text{C}$)		P_D	40	W
Single pulse avalanche energy (Note 2)		E_{AS}	222	mJ
Avalanche current		I_{AR}	10	A
Repetitive avalanche energy (Note 3)		E_{AR}	4	mJ
Channel temperature		T_{ch}	150	$^\circ\text{C}$
Storage temperature range		T_{stg}	-55~150	$^\circ\text{C}$



Weight: 1.9 g (typ.)

Thermal Characteristics

Characteristics	Symbol	Max	Unit
Thermal reverse, channel to case	$R_{th(ch-c)}$	3.125	$^{\circ}C / W$
Thermal reverse, channel to ambient	$R_{th(ch-a)}$	62.5	$^{\circ}C / W$

Note 1: Please use devices on condition that the channel temperature is below 150°C.

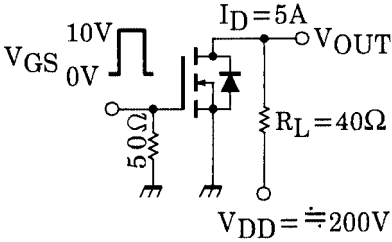
Note 2: $V_{DD} = 90 \text{ V}$, $T_{ch} = 25^\circ\text{C}$ (initial), $L = 3.7 \text{ mH}$, $R_G = 25 \text{ }\Omega$, $I_{AR} = 10 \text{ A}$

Note 3: Repetitive rating; Pulse width limited by maximum channel temperature.

This transistor is an electrostatic sensitive device.

Please handle with caution.

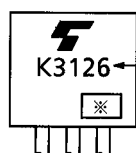
Electrical Characteristics (Ta = 25°C)

Characteristics		Symbol	Test Condition	Min	Typ.	Max	Unit
Gate leakage current		I_{GSS}	$V_{GS} = \pm 25 \text{ V}, V_{DS} = 0 \text{ V}$	—	—	± 10	μA
Gate-source breakdown voltage		$V_{(BR)GSS}$	$I_G = \pm 10 \mu\text{A}, V_{DS} = 0 \text{ V}$	± 30	—	—	V
Drain cut-off current		I_{DSS}	$V_{DS} = 450 \text{ V}, V_{GS} = 0 \text{ V}$	—	—	100	μA
Drain-source breakdown voltage		$V_{(BR)DSS}$	$I_D = 10 \text{ mA}, V_{GS} = 0 \text{ V}$	450	—	—	V
Gate threshold voltage		V_{th}	$V_{DS} = 10 \text{ V}, I_D = 1 \text{ mA}$	2.4	—	3.4	V
Drain-source ON resistance		$R_{DS(ON)}$	$V_{GS} = 10 \text{ V}, I_D = 5 \text{ A}$	—	0.48	0.65	Ω
Forward transfer admittance		$ Y_{fs} $	$V_{DS} = 10 \text{ V}, I_D = 5 \text{ A}$	3.5	7.5	—	S
Input capacitance		C_{iss}	$V_{DS} = 10 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$	—	1400	—	pF
Reverse transfer capacitance		C_{rss}		—	240	—	
Output capacitance		C_{oss}		—	590	—	
Switching time	Rise time	t_r	 $I_D = 5 \text{ A}$ $V_{GS} = 10 \text{ V}, 0 \text{ V}$ 50Ω $R_L = 40 \Omega$ $V_{DD} \approx 200 \text{ V}$ Duty $\leq 1\%$, $t_w = 10 \mu\text{s}$	—	35	—	ns
	Turn-on time	t_{on}		—	50	—	
	Fall time	t_f		—	80	—	
	Turn-off time	t_{off}		—	260	—	
Total gate charge (Gate-source plus gate-drain)		Q_g	$V_{DD} \approx 400 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 10 \text{ A}$	—	35	—	nC
Gate-source charge		Q_{gs}		—	19	—	
Gate-drain ("miller") charge		Q_{gd}		—	16	—	

Source-Drain Ratings and Characteristics (Ta = 25°C)

Characteristics	Symbol	Test Condition	Min	Typ.	Max	Unit
Continuous drain reverse current (Note 1)	I_{DR}	—	—	—	10	A
Pulse drain reverse current (Note 1)	I_{DRP}	—	—	—	40	A
Forward voltage (diode)	V_{DSF}	$I_{DR} = 10 \text{ A}, V_{GS} = 0 \text{ V}$	—	—	-1.7	V
Reverse recovery time	t_{rr}	$I_{DR} = 10 \text{ A}, V_{GS} = 0 \text{ V}$	—	1400	—	ns
Reverse recovery charge	Q_{rr}	$dI_{DR} / dt = 100 \text{ A} / \mu\text{s}$	—	14	—	μC

Marking



TYPE

※ Lot Number



Month (Starting from Alphabet A)



Year (Last Number of the Christian Era)

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